

Model: FVXO-LC52 SERIES

Freq: 0.75 MHz to 1.0GHz

VDS 5 x 3.2mm 2.5V V C X O

Features

- XTREMELY Low Jitter
- Low Cost
- XPRESS Delivery
- Frequency Resolution to six decimal places
- Absolute Pull Range (APR) of ±50ppm
- -20 to +70°C or -40 to +85°C operating temperatures
- Tri-State Enable / Disable Feature
- Industry Standard Package, Footprint & Pin-Out
- Fully RoHS compliant
- Gold over Nickel Termination Finish
- Serial ID with Comprehensive Traceability



For more information -- Click on the drawing

Description

The Fox XPRESSO Crystal Oscillator is a breakthrough in configurable Frequency Control Solutions. XPRESSO utilizes a family of proprietary ASICs, designed and developed by Fox, with a key focus on noise reduction technologies.

The 3rd order Delta Sigma Modulator reduces noise to the levels that are comparable to traditional Bulk Quartz and SAW oscillators. The ASICs family has ability to select the output type, input voltages, and temperature performance features.

With the XPRESS lead-time, low cost, low noise, wide frequency range, excellent ambient performance, XpressO is an excellent choice over the conventional technologies.

Finished XPRESSO parts are 100% final tested.



Rev. 04/02/2008





nage

Applications

- ANY application requiring an oscillator
- SONET
- Ethernet
- Storage Area Network
- Broadband Access
- Microprocessors / DSP / FPGA
- Industrial Controllers
- Test and Measurement Equipment
- Fiber Channel

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This example, FVXO-LC52BR-644.53125 = Voltage Controlled, LVDS Output, Ceramic, 5 x 3.2mm Package, 2.5V, ±50 PPM Absolute Pull Range, -40 to +85°C Temperature Range, at 644.53125 MHz

Absolute Maximum Ratings (Useful life may be impaired. For user guidelines only, not tested. Operation is only guaranteed for voltage and temperature specifications in Electrical Characteristics section.)				
Parameters Symbol Condition Maximum Value (unless otherwise note)				
Input Voltage	V _{DD}		-0.5V to +5.0V	
Operating Temperature	T _{AMAX}		–55°C to +105°C	
Storage Temperature	T _{STG}		–55°C to +125°C	
Junction Temperature			150°C	
ESD Sensitivity	HBM	Human Body Model	> 1 kV	



Electrical Characteristics					
Symbol	Condition	Maximum Value (unless otherwise noted)			
Fo		0.750 MHz to 1.0 GHz			
APR		± 50 ppm MIN			
T _o T _{stg}	Standard operating Optional operating Storage	-20°C to +70°C -40°C to +85°C -55°C to +125°C			
V _{DD}	Standard	2.5V ± 5%			
I _{DD}	0.75 ~ 20.000 MHz 20.000+ ~ 220.000 MHz 220.000+ ~ 630.000 MHz 630.000+ MHz ~ 1.000 GHz	26 mA 34 mA 44 mA 65 mA			
	Standard	100 Ohms Typ.			
Ts		10 mS			
		100 nS			
MSL	JEDEC J-STD-20	1			
		Au			
	Symbol F ₀ APR T ₀ T _{STG} V _{DD} I _{DD}	$\begin{array}{ c c c } \hline Symbol & Condition \\ \hline F_{O} & \\ \hline APR & \\ \hline T_{O} & Standard operating \\ \hline Optional operating \\ \hline Optional operating \\ \hline Storage \\ \hline V_{DD} & Standard \\ \hline V_{DD} & Standard \\ \hline I_{DD} & 0.75 \sim 20.000 \ \text{MHz} \\ 20.000+ \sim 220.000 \ \text{MHz} \\ 220.000+ \sim 630.000 \ \text{MHz} \\ 220.000+ \ MHz \sim 1.000 \ \text{GHz} \\ \hline Standard \\ \hline T_{S} & \\ \hline \end{array}$			

Note 1 – Inclusive of 25°C tolerance, operating temperature range, input voltage change, load change, aging, shock and vibration.

Frequency Control (V_c) Input -- pin # 1

Parameters	Symbol	Condition	Maximum Value (unless otherwise noted)
Control Voltage Tuning Slope ¹		0V to V_{DD}	40 ~ 75 ppm/V Typ ²
Control Voltage Linearity ²	L _{VC}		± 10%
Control Voltage Tuning Range	Vc		0V ~ 2.5V
Modulation Bandwidth	BW		10 kHz Min
Nominal Control Voltage	V _{CNOM}	@ f ₀	1.25V

NOTES:

¹ Actual slope is affected by frequency and accuracy settings.

² For an example of linearity, see the graph below. (*The middle line represents the default Fox factory setting*)







Output Wave Characteristics

Parameters	Symbol	Condition	Maximum Value (unless otherwise noted)		
Differential Output Voltage	V _{OD}	0.75 MHz to 1.0 GHz	0.4V Typ.		
Output Offset Voltage	Vos		1.25V Typ.		
Output Symmetry (See Drawing Below)		@ 50% V _{P-P} Level	45% ~ 55%		
Output Enable (PIN # 2) Voltage	V _{IH}		≥ 70% V _{DD}		
Output Disable (PIN # 2) Voltage	VIL		$\leq 30\% V_{DD}$		
Cycle Rise Time (See Drawing Below)	T _R	20%~80% Vp-p	400 pS		
Cycle Fall Time (See Drawing Below)	T _F	80%~20% Vp-p	400 pS		



Oscillator Symmetry

Ideally, Symmetry should be 50/50 for 1/2 period -- Other expressions are 45/55 or 55/45







Phase Noise



Jitter is frequency dependent. Below are typical values at select frequencies.

LVDS Phase Jitter & Time Interval Error (TIE)				
Frequency	Phase Jitter (12kHz to 20MHz)	TIE (Sigma of Jitter Distribution)	Units	
62.5 MHz	2.12	3.1	pS RMS	
156.25 MHz	1.04	3.5	pS RMS	
212.5 MHz	1.35	4.2	pS RMS	
622.08MHz	1.30	3.7	pS RMS	

Phase Jitter is integrated from HP3048 Phase Noise Measurement System; measured directly into 50 ohm input; V_{DD} = 2.5V. <u>TIE</u> was measured on LeCroy LC684 Digital Storage Scope, directly into 50 ohm input, with Amherst M1 software; V_{DD} = 2.5V. *Per MJSQ spec (Methodologies for Jitter and Signal Quality specifications)*

LVDS Random & Deterministic Jitter Composition				
Frequency	Random (Rj) (pS RMS)	Deterministic (Dj) (pS P-P)	Total Jitter (Tj) (14 x Rj) + Dj	
62.5 MHz	1.35	8.4	27.6 pS	
156.25 MHz	1.40	9.2	29.2pS	
212.5 MHz	1.42	10.9	31.2 pS	
622.08 MHz	1.18	10.4	27.2 pS	

<u>**Ri and Di**</u>, measured on LeCroy LC684 Digital Storage Scope, directly into 50 ohm input, with Amherst M1 software. Per **MJSQ** spec (Methodologies for Jitter and Signal Quality specifications)





Pin #	Name	Туре	Function
1	Vc	Control	Frequency Control by changing voltage
2	E/D ¹	Logic	Enable / Disable Control of Output (0 = Disabled)
3	GND	Ground	Electrical Ground for V _{DD}
4	Output	Output	LVDS Oscillator Output
5	Output 2	Output	Complementary LVDS Output
6	V _{DD} ²	Power	Power Supply Source Voltage
OTES	¹ Includes pull-up	resistor to V _{DD} to pr	ovide output when the pin (2)is No Connect.
	² Installation shou		bypass capacitor placed between V _{DD} power supply line noise.

Terminations as viewed from the Top NOTE: XPRESSO LVDS VCXOs are designed to fit on Industry Standard, 6 pad layouts

4

Output

GND

3



Enable / Disable Control	
Pin # 2 (state)	Output (Pin # 4, Pin # 5)
OPEN (No Connection)	ACTIVE Output
"1" Level V _{IH} ≥ 70% V _{DD}	ACTIVE Output
"0" Level $V_{IL} \leq 30\% V_{DD}$	High Impedance





Mechanical Dimensional Drawing & Pad Layout



Pin Connections			
#1)	Vc	#4)	Output
#2)	E/D	#5)	Output 2
#3)	GND	#6)	V _{DD}

Drawing is for reference to critical specifications defined by size measurements. Certain non-critical visual attributes, such as side castellations, reference pin shape, etc. may vary





Tape and Reel Dimensions



Labeling (Reels and smaller packaging are labeled with the below)



An additional identification code is contained internally if tracking should ever be necessary





Traceability – LOT Number & Serial Identification

LOT Number

The LOT Number has direct ties to the customer purchase order. The LOT Number is marked on the "Reel" label, and also stored internally on non-volatile memory inside the XPRESSO part. XPRESSO parts that are shipped Tape and Reel, are also placed in an Electro Static Discharge (ESD) bag and will have the LOT Number labeled on the exterior of the ESD bag.

It is recommended that the XPRESSO parts remain in this ESD bag during storage for protection and identification.

If the parts become separated from the label showing the LOT Number, it can be retrieved from inside one of the parts, and the information that can be obtained is listed below:

- Customer Purchase Order Number
- Internal Fox Sales Order Number
- Dates that the XPRESSO part was shipped from the factory
- The assigned customer part number
- The specification that the part was designed for

Serial Identification

The Serial ID is the individualized information about the configuration of that particular XPRESSO part. The Serial ID is unique for each and every XPRESSO part, and can be read by special Fox equipment.

With the Serial ID, the below information can be obtained about that individual, XPRESSO part:

- Equipment that the XPRESSO part was configured on
- Raw material used to configure the XPRESSO part
- Traceability of the raw material back to the foundries manufacturing lot
- Date and Time that the part was configured
- Any optimized electrical parameters based on customer specifications
- Electrical testing of the actual completed part
- Human resource that was monitoring the configuration of the part

Fox has equipment placed at key Fox locations World Wide to read the Lot Identification and Serial Number of any XPRESSO part produced and can then obtain the information from above within 24 hours





RoHS Material Declaration

	Material Name	Component	Content	Content	
			(mg)	(w t %)	(CAS Number)
Cover	Kovar	Nickel (Ni)	1.890	3.09%	7440-02-0
		Cobalt (Co)	1.113	1.82%	7440-48-4
		Iron (Fe)	3.540	5.78%	7439-89-6
Base	Ceramic	Alumina (Al ₂ O ₃)	35.484	57.98%	1344-28-1
		Silicon Oxide (SiO ₂)	1.733	2.83%	14808-60-7
		Chromium Oxide (Cr ₂ O ₃)	0.268	0.44%	1308-38-9
		Molybdenum Oxide (MoO ₂)	0.364	0.59%	18868-43-4
		Magnesium Oxide (MgO)	0.234	0.38%	1309-48-4
		Calcium Oxide (CaO)	0.253	0.41%	1305-78-8
	+ Metallization	Tungsten (W)	6.290	10.28%	7440-33-7
		Molybdenum (Mo)	0.195	0.32%	7439-98-7
	+ Nickel Plating	Nickel (Ni)	0.810	1.32%	7440-02-0
		Cobalt (Co)	0.203	0.33%	7440-48-4
	+ Gold Plating	Gold (Au)	0.281	0.46%	7440-57-5
	+Seal ring	Iron (Fe)	2.438	3.98%	7439-89-6
		Nickel (Ni)	1.309	2.14%	7440-02-0
		Cobalt (Co)	0.768	1.25%	7440-48-4
	+silver solder	Silver (Ag)	1.191	1.95%	7440-22-4
		Copper (Cu)	0.210	0.34%	7440-50-8
ΙC	ΙC	Aluminum (Al)	0.0021	0.00343%	7429-90-5
		Silicon (Si)	0.950	1.55%	7440-21-3
	Gold	Gold (Au)	0.480	0.784%	7440-57-5
	Adhesive	Silver (Ag)	0.000210	0.000343%	7440-22-4
		Ероху	0.0000700	0.0001144%	
Crystal	Crystal	Silicon Dioxide (SiO ₂)	1.170	1.91%	14808-60-7
	Electrode	Silver (Ag)	0.019	0.0310%	7440-22-4
		Nickel (Ni)	0.000159	0.000260%	7440-02-0
	Adhesive	Silver (Ag)	0.00037	0.000605%	7440-22-4
		Silicon (Si)	0.000125	0.000204%	7440-21-3
TOTAL			61.196	100.00%	





3rd Party (SGS) Material Report

SGS				
Test Repo	ort	No. 2053204/EC	Date : Mar 01 2006	Page 1 of 2
FOX ELECTRONICS 5570 ENTERPRISE P/ FT. MYERS, FL 33905				
Report on the submitte	ed sample	said to be CERAMIC SEA	M SEAL OSCILLATOR.	
SGS Job No. Supplier / Manufacture Sample Receiving Dat Testing Period		1981176 FOX ELECTRONICS FEB 17 2006 FEB 18 - 24 2006		
Test Requested :	1) 2) 3) 4) 5)	To determine the Lead Co To determine the Mercury To determine the Hexaval To determine PBBs (polyb	n Content in the submitted s ntent in the submitted sampl Content in the submitted sal ent Chromium Content on th rominated biphenyls) and Pi thers) of the submitted sam	le. mple. e submitted sampl BDEs
Test Method :	1-3) 4) 5)	Emission Spectrometry (IC With reference to EPA Me The sample was alkaline of analyzed by using Colorim Spectrophotometer).	/ Inductively Coupled Argon P-AES).	od 3060A, and ther Vis
Test Results :	1-5)	Please refer to next page.		
Signed for and on beha SGS Hong Kong Ltd	alf of			

Ho K a Ting, Family Laboratory Executive

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Party (SGS) Material Report (continued) 3^{ra}



Test Report

No. 2053204/EC

Date : Mar 01 2006

Page 2 of 2

Test Results

Test Item	<u>1</u>	Detection Limit
1) Cadmium (Cd)	ND	2 ppm
2) Lead (Pb)	ND	2 ppm
3) Mercury (Hg)	ND	2 ppm
 Hexavalent Chromium (Cr⁶⁺) 	ND	2 ppm

(Results shown are of the total weight of samples)

Note : ppm = mg/kg

ND = Not Detected Not detected is reported when the reading is less than detection limit value

5)		
Flame Retardants	1	Detection Limit
Polybrominated Biphenyls (PBBs)		
Monobromobiphenyl	ND	5 ppm
Dibromobiphenyl	ND	5 ppm
Tribromobiphenyl	ND	5 ppm
Tetrabromobiphenyl	ND	5 ppm
Pentabromobiphenyl	ND	5 ppm
Hexabromobiphenyl	ND	5 ppm
Heptabromobiphenyl	ND	5 ppm
Octabromobiphenyl	ND	5 ppm
Nonabromobiphenyl	ND	5 ppm
Decabromobiphenyl	ND	5 ppm
Polybrominated Diphenylethers (PBDEs)		
Monobromodiphenyl ether	ND	5 ppm
Dibromodiphenyl ether	ND	5 ppm
Tribromodiphenyl ether	ND	5 ppm
Tetrabromodiphenyl ether	ND	5 ppm
Pentabromodiphenyl ether	ND	5 ppm
Hexabromodiphenyl ether	ND	5 ppm
Heptabromodiphenyl ether	ND	5 ppm
Octabromodiphenyl ether	ND	5 ppm
Nonabromodiphenyl ether	ND	5 ppm
Decabromodiphenyl ether	ND	5 ppm

Note ppm = mg/kg

ND = Not Detected

Not detected is reported when the reading is less than detection limit value.

Sample Description: 1. Black Ceramic w/ Silvery, Golden Metal w/ Silvery Chips

*** End of Report ***

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Mechanical Testing

Parameter	Test Method
Mechanical Shock	Drop from 75cm to hardwood surface – 3 times
Mechanical Vibration	10~55Hz, 1.5mm amplitude, 1 Minute Sweep 2 Hours each in 3 Directions (X, Y, Z)
High Temperature Burn-in	Under Power @ 125°C for 2000 Hours (results below)
Hermetic Seal	He pressure: 4 \pm 1 kgf / cm ² 2 Hour soak

2,000 Hour Burn-In

Burn-In Testing – under power 2000 Hours, 125°C







MTTF / FITS Calculations

Products are grouped together by process for MTTF calculations. (All XpressO output and package types are manufactured with the same process)

Number of Parts Tested:
Number of Failures:360 (120 of each output type: HCMOS, LVDS, LVPECL)Number of Failures:
Test Temperature:125°CNumber of Hours:
20002000

MTTF was calculated using the following formulas:

[1.] Device Hours (devhrs) = (number of devices) x (hours at elevated temperature in °K)

 $[2.] MTTF = \frac{devhrs \times af \times 2}{\chi^2}$

[3.] FITS = $\frac{1}{MTTF}$ * 10⁹

Where:

Label	Name	Formula/Value
af	Acceleration Factor	$\boldsymbol{\varrho}^{(\frac{eV}{k})\times(\frac{1}{t_1}-\frac{1}{t_2})}$
eV	Activation Energy	0.40 V
k	Bolzman's Constant	8.62 X 10⁻⁵ <i>eV</i> /°K
t ₁		Operating Temperature (°K)
t ₂		Accelerated Temperature (°K)
Θ	Theta	Confidence Level (60% industry standard)
r	Failures	Number of failed devices
X ²	Chi-Square	statistical significance for bivariate tabular analysis [table look- up] based on assumed Θ (Theta – confidence) and number of failures (r) For zero failures (60% Confidence): $\chi^2 = 1.830$

DEVICE-HOURS = 360 x 2000 HOURS = 720,000

ACCELERATION FACTOR = $e^{(\frac{0.40}{8.625})\times(\frac{1}{298}-\frac{1}{398})} = 49.91009$

MTTF = $\frac{720,000 \times 49.91009 \times 2}{1.833}$ = 39,209,238 Hours

Failure Rate = $\frac{1.833}{720,000 \times 49.91009 \times 2}$ = 2.55E-8

FITS = Failure Rate *1E9 = 26





Notes :

For the complete product line of *XpressO* products visit http://www.foxonline.com/xpressomain.htm

Patent Numbers: US 6,664,860, US 5,960,403, US 5,952,890; US 5,960,405; US 6,188,290; Foreign Patents: R.S.A. 98/0866, R.O.C. 120851; Singapore 67081, 67082; EP 0958652 China ZL 98802217.6, Malaysia MY-118540-A, Philippines 1-1998-000245, Hong Kong #HK1026079, Mexico #232179 US and Foreign Patents Pending XpressO[™] Fox Electronics

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The above specifications, having been carefully prepared and checked, is believed to be accurate at the time of publication; however, no responsibility is assumed by Fox Electronics for inaccuracies.

